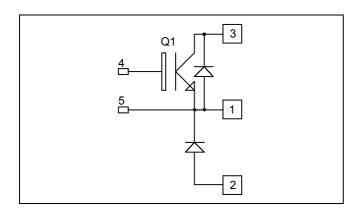


Buck Chopper Trench + Field Stop IGBT4 Power Module

$$V_{CES} = 1200V$$

 $I_{C} = 475A$ @ $T_{C} = 80^{\circ}C$



Application

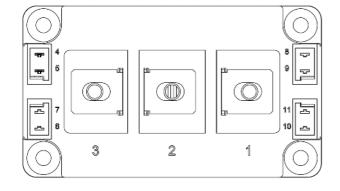
- AC and DC motor control
- Switched Mode Power Supplies

Features

- Trench + Field Stop IGBT 4 Technology
 - Low voltage drop
 - Low leakage current
 - Low switching losses
 - Soft recovery parallel diodes
 - Low diode VF
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- High level of integration
- M6 power connectors

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CEsat}
- **RoHS Compliant**



Absolute maximum ratings

| Symbol | Parameter | | Max ratings | Unit |
|-------------|---------------------------------------|----------------------|--------------|------|
| V_{CES} | Collector - Emitter Breakdown Voltage | | 1200 | V |
| $I_{\rm C}$ | Continuous Collector Current | $T_C = 25^{\circ}C$ | 610 | |
| | Continuous Conector Current | $T_C = 80$ °C | 475 | A |
| I_{CM} | Pulsed Collector Current | $T_C = 25^{\circ}C$ | 900 | |
| V_{GE} | Gate – Emitter Voltage | | ±20 | V |
| P_{D} | Maximum Power Dissipation | $T_C = 25^{\circ}C$ | 2080 | W |
| RBSOA | Reverse Bias Safe Operating Area | $T_j = 125^{\circ}C$ | 800A @ 1100V | |

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|----------------------|--------------------------------------|--|---------------------|-----|-----|-----|------|
| I_{CES} | Zero Gate Voltage Collector Current | $V_{GE} = 0V, V_{CE} = 1200V$ | | | | 5 | mA |
| V _{CE(sat)} | Collector Emitter saturation Voltage | - GL | $T_j = 25^{\circ}C$ | | 1.8 | 2.2 | V |
| | | | $T_j = 125$ °C | | 2.2 | | v |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE} = V_{CE}$, $I_C = 15 \text{mA}$ | | 5.0 | 5.8 | 6.5 | V |
| I_{GES} | Gate – Emitter Leakage Current | $V_{GE} = 20V, V_{CE} = 0V$ | | | | 400 | nA |

Dynamic Characteristics

| Symbol | Characteristic | Test Conditions | Test Conditions | | Typ | Max | Unit |
|------------------|------------------------------|------------------------------------|---|----|------|-----|------|
| Cies | Input Capacitance | $V_{GE} = 0V$ | | | 24.6 | | |
| Coes | Output Capacitance | $V_{CE} = 25V$ | | | 1.62 | | nF |
| C_{res} | Reverse Transfer Capacitance | f = 1MHz | | | 1.38 | | |
| Q_{G} | Gate charge | V_{GE} = -8V / 15V I_{C} =400A | ; V _{CE} =600V | | 2.3 | | μС |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switch | ning (25°C) | | 200 | | ns |
| $T_{\rm r}$ | Rise Time | $V_{GE} = \pm 15V$ | | | 40 | | |
| $T_{d(off)}$ | Turn-off Delay Time | $V_{CE} = 600V$ $I_{C} = 400A$ | | | 400 | | |
| $T_{\rm f}$ | Fall Time | $R_G = 1\Omega$ | | 70 | | İ | |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switch | ning (150°C) | | 220 | | |
| $T_{\rm r}$ | Rise Time | $V_{GE} = \pm 15V$ $V_{CE} = 600V$ | $V_{GE} = \pm 15V$ $V_{GE} = 600V$ | | | | ns |
| $T_{d(off)}$ | Turn-off Delay Time | $I_{\rm C} = 400 {\rm A}$ | | | 500 | | 115 |
| T_{f} | Fall Time | $R_G = 1\Omega$ | | | 80 | | |
| Eon | Turn-on Switching Energy | $V_{GE} = \pm 15V$ $V_{CE} = 600V$ | $T_J = 150^{\circ}C$ | | 33 | | mJ |
| E _{off} | Turn-off Switching Energy | $I_{C} = 400A$ $R_{G} = 1\Omega$ | $T_{\rm J} = 150^{\circ}{\rm C}$ | | 42 | | mJ |
| I_{sc} | Short Circuit data | | $V_{GE} \le 15V$; $V_{Bus} = 900V$ $t_p \le 10 \mu s$; $T_j = 150 ^{\circ}C$ | | 1600 | | A |

Diode ratings and characteristics

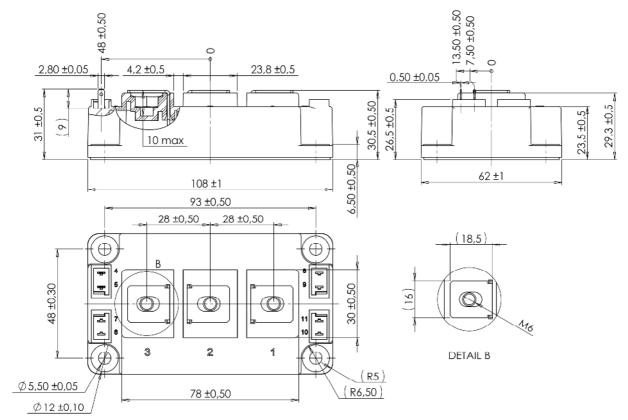
| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|----------------------------|------------------------------------|---|---|------|------|------|------|
| V_{RRM} | Maximum Repetitive Reverse Voltage | | | 1200 | | | V |
| I_{RRM} | Maximum Reverse Leakage Current | V _R =1200V | $T_j = 25^{\circ}C$ | | | 250 | μA |
| I_{F} | DC Forward Current | | $T_{\rm j} = 150^{\circ}{\rm C}$ $T_{\rm C} = 80^{\circ}{\rm C}$ | | 400 | 2000 | A |
| V_{F} | Diode Forward Voltage | $I_F = 400A$ $V_{GE} = 0V$ | $T_j = 25^{\circ}C$ | | 1.7 | 2.2 | V |
| v _F | | | $T_{j} = 150^{\circ}C$ | | 1.65 | | |
| t _{rr} | Reverse Recovery Time | $ \begin{aligned} & I_F = 400A \\ & V_R = 600V \\ & di/dt = 7000A/\mu s \end{aligned} $ | $T_j = 25^{\circ}C$ | | 155 | | ns |
| ·rr | | | $T_{j} = 150^{\circ}C$ | | 300 | | |
| Q_{rr} | Reverse Recovery Charge | | $T_j = 25^{\circ}C$ | | 37.2 | | μС |
| Qrr | | | $T_j = 150$ °C | | 78 | | μС |
| E_{rr} | Reverse Recovery Energy | · | $T_j = 25$ °C | | 16 | | mJ |
| \mathbf{L}_{II} | | | $T_{j} = 150^{\circ}C$ | | 32 | | 1113 |



Thermal and package characteristics

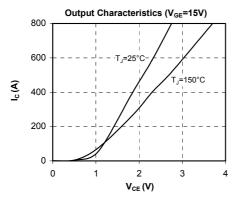
| Symbol | Characteristic | | | Min | Тур | Max | Unit |
|------------------|--|---------------|-------|------|-----|--------|------|
| R_{thJC} | Junction to Case Thermal Resistance | | IGBT | | | 0.072 | °C/W |
| 1\(\text{thJC}\) | | | Diode | | | 0.14 | C/ W |
| V_{ISOL} | RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz | | | 4000 | | | V |
| T_{J} | Operating junction temperature range -40 1 | | 175 | | | | |
| T_{STG} | Storage Temperature Range | | | -40 | | 125 | °C |
| $T_{\rm C}$ | Operating Case Temperature | | | -40 | | 125 | |
| Torque | Mounting torque For terminals To Heatsink | For terminals | M6 | 3 | | 5 | N.m |
| | | M6 | 3 | | 5 | 18.111 | |
| Wt | Package Weight | | | | | 350 | g |

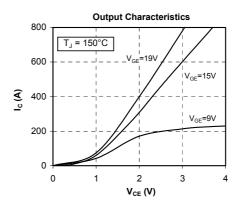
D3 Package outline (dimensions in mm)

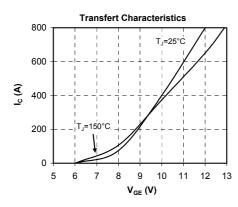


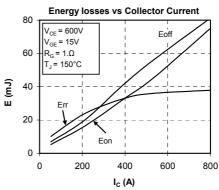


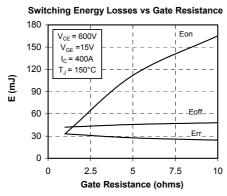
Typical Performance Curve

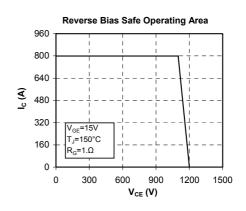


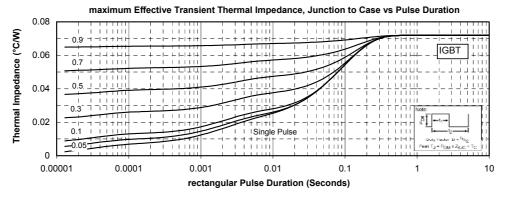




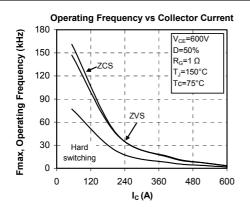


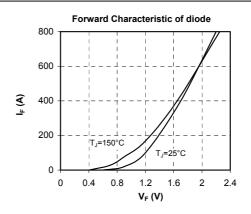


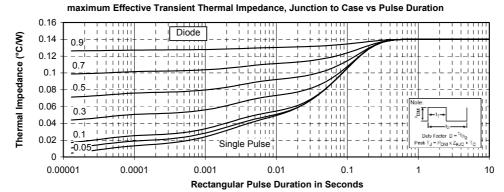












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